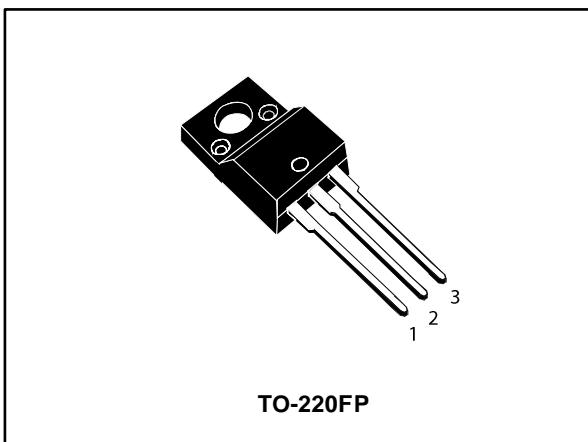
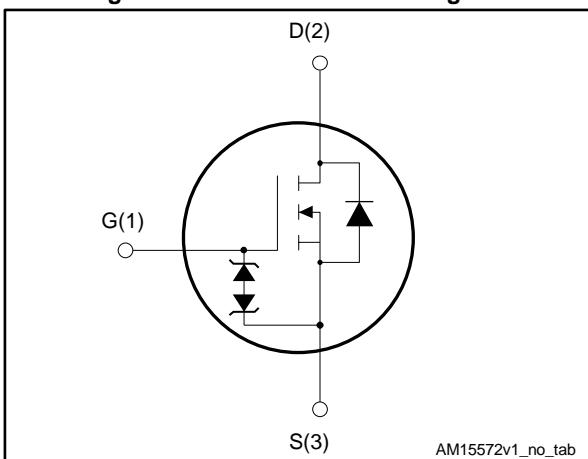


## N-channel 650 V, 0.093 Ω typ., 32 A MDmesh™ DM2 Power MOSFET in a TO-220FP package

Datasheet - production data



**Figure 1: Internal schematic diagram**



### Features

Order code	V <sub>DS</sub>	R <sub>DS(on)</sub> max.	I <sub>D</sub>	P <sub>TOT</sub>
STF35N65DM2	650 V	0.110 Ω	32 A	40 W

- Fast-recovery body diode
- Extremely low gate charge and input capacitance
- Low on-resistance
- 100% avalanche tested
- Extremely high dv/dt ruggedness
- Zener-protected

### Applications

- Switching applications

### Description

This high voltage N-channel Power MOSFET is part of the MDmesh™ DM2 fast recovery diode series. It offers very low recovery charge ( $Q_{rr}$ ) and time ( $t_{rr}$ ) combined with low  $R_{DS(on)}$ , rendering it suitable for the most demanding high efficiency converters and ideal for bridge topologies and ZVS phase-shift converters.

**Table 1: Device summary**

Order code	Marking	Package	Packing
STF35N65DM2	35N65DM2	TO-220FP	Tube

## Contents

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# 1 Electrical ratings

Table 2: Absolute maximum ratings

Symbol	Parameter	Value	Unit
$V_{GS}$	Gate-source voltage	$\pm 25$	V
$I_D$	Drain current (continuous) at $T_{case} = 25^\circ\text{C}$	32	A
	Drain current (continuous) at $T_{case} = 100^\circ\text{C}$	20	
$I_{DM}^{(1)}$	Drain current (pulsed)	90	A
$P_{TOT}$	Total dissipation at $T_{case} = 25^\circ\text{C}$	40	W
$dv/dt^{(2)}$	Peak diode recovery voltage slope	50	V/ns
$dv/dt^{(3)}$	MOSFET dv/dt ruggedness	50	
$V_{ISO}$	Insulation withstand voltage (RMS) from all three leads to external heat-sink ( $t = 1 \text{ s}$ ; $T_c = 25^\circ\text{C}$ )	2.5	kV
$T_{stg}$	Storage temperature range	-55 to 150	$^\circ\text{C}$
$T_j$	Operating junction temperature range		

**Notes:**

(1)Pulse width is limited by safe operating area.

(2) $I_{SD} \leq 32 \text{ A}$ ,  $di/dt=900 \text{ A}/\mu\text{s}$ ,  $V_{DS}$  peak <  $V_{(BR)DSS}$ ,  $V_{DD} = 80\%$   $V_{(BR)DSS}$ (3) $V_{DS} \leq 520 \text{ V}$ 

Table 3: Thermal data

Symbol	Parameter	Value	Unit
$R_{thj-case}$	Thermal resistance junction-case	3.1	$^\circ\text{C}/\text{W}$
$R_{thj-amb}$	Thermal resistance junction-ambient	62.5	

Table 4: Avalanche characteristics

Symbol	Parameter	Value	Unit
$I_{AR}$	Avalanche current, repetitive or non-repetitive	4	A
$E_{AS}^{(1)}$	Single pulse avalanche energy	1150	mJ

**Notes:**(1)Starting  $T_j = 25^\circ\text{C}$ ,  $I_D = I_{AR}$ ,  $V_{DD} = 50 \text{ V}$ .

## 2 Electrical characteristics

( $T_{case} = 25^\circ C$  unless otherwise specified)

**Table 5: Static**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{(BR)DSS}$	Drain-source breakdown voltage	$V_{GS} = 0 V, I_D = 1 mA$	650			V
$I_{DSS}$	Zero gate voltage drain current	$V_{GS} = 0 V, V_{DS} = 650 V$			1	$\mu A$
		$V_{GS} = 0 V, V_{DS} = 650 V, T_{case} = 125^\circ C^{(1)}$			100	
$I_{GSS}$	Gate-body leakage current	$V_{DS} = 0 V, V_{GS} = \pm 25 V$			$\pm 5$	$\mu A$
$V_{GS(th)}$	Gate threshold voltage	$V_{DS} = V_{GS}, I_D = 250 \mu A$	3	4	5	V
$R_{DS(on)}$	Static drain-source on-resistance	$V_{GS} = 10 V, I_D = 16 A$		0.093	0.110	$\Omega$

**Notes:**

<sup>(1)</sup>Defined by design, not subject to production test.

**Table 6: Dynamic**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$C_{iss}$	Input capacitance	$V_{DS} = 100 V, f = 1 MHz, V_{GS} = 0 V$	-	2540	-	pF
$C_{oss}$	Output capacitance		-	115	-	
$C_{rss}$	Reverse transfer capacitance		-	2.5	-	
$C_{oss\ eq.}^{(1)}$	Equivalent output capacitance	$V_{DS} = 0$ to $520 V, V_{GS} = 0 V$	-	204	-	pF
$R_G$	Intrinsic gate resistance	$f = 1 MHz, I_D = 0 A$	-	4.2	-	$\Omega$
$Q_g$	Total gate charge	$V_{DD} = 520 V, I_D = 32 A, V_{GS} = 0$ to $10 V$ (see <a href="#">Figure 15: "Test circuit for gate charge behavior"</a> )	-	56.3	-	nC
$Q_{gs}$	Gate-source charge		-	12.7	-	
$Q_{gd}$	Gate-drain charge		-	27.6	-	

**Notes:**

<sup>(1)</sup> $C_{oss\ eq.}$  is defined as a constant equivalent capacitance giving the same charging time as  $C_{oss}$  when  $V_{DS}$  increases from 0 to 80%  $V_{DSS}$ .

**Table 7: Switching times**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$t_{d(on)}$	Turn-on delay time	$V_{DD} = 325 V, I_D = 16 A, R_G = 4.7 \Omega, V_{GS} = 10 V$ (see <a href="#">Figure 14: "Test circuit for resistive load switching times"</a> and <a href="#">Figure 19: "Switching time waveform"</a> )	-	23.4	-	ns
$t_r$	Rise time		-	23	-	
$t_{d(off)}$	Turn-off delay time		-	72	-	
$t_f$	Fall time		-	10.4	-	

Table 8: Source-drain diode

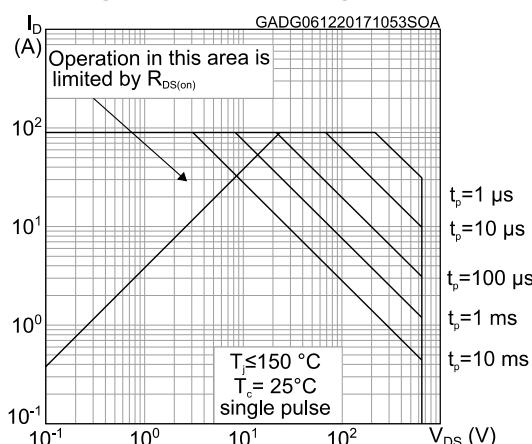
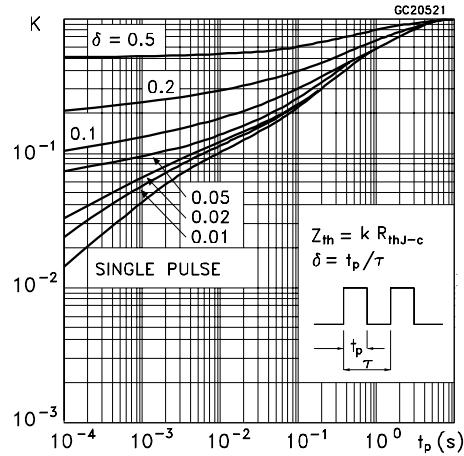
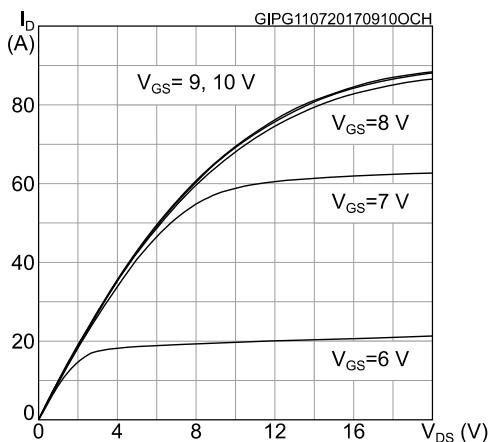
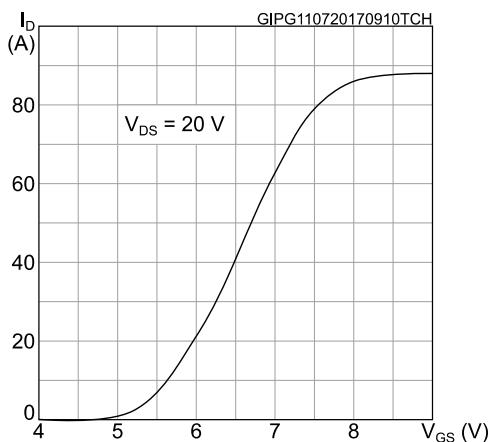
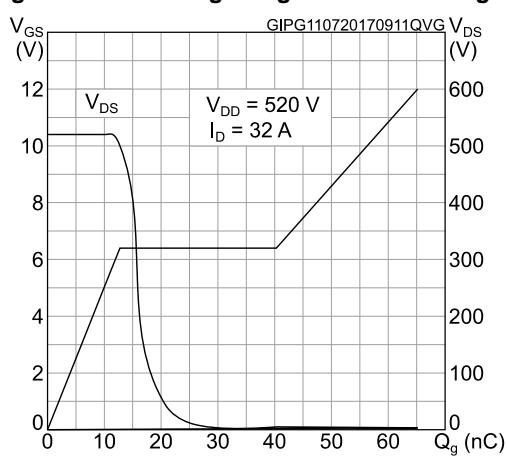
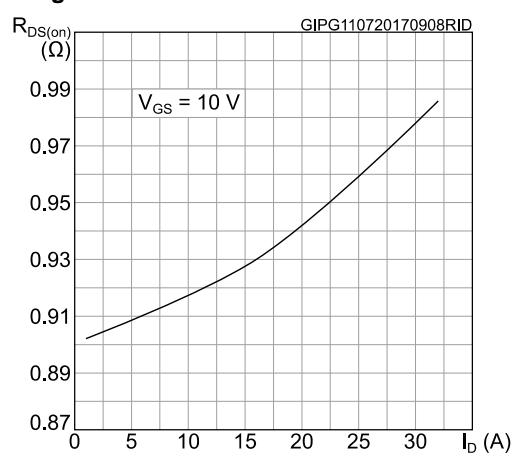
Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$I_{SD}$	Source-drain current		-		32	A
$I_{SDM}^{(1)}$	Source-drain current (pulsed)		-		90	A
$V_{SD}^{(2)}$	Forward on voltage	$V_{GS} = 0 \text{ V}, I_{SD} = 32 \text{ A}$	-		1.6	V
$t_{rr}$	Reverse recovery time	$I_{SD} = 32 \text{ A}, dI/dt = 100 \text{ A}/\mu\text{s}, V_{DD} = 60 \text{ V}$ (see <i>Figure 16: "Test circuit for inductive load switching and diode recovery times"</i> )	-	100		ns
$Q_{rr}$	Reverse recovery charge		-	0.42		$\mu\text{C}$
$I_{RRM}$	Reverse recovery current		-	8.4		A
$t_{rr}$	Reverse recovery time	$I_{SD} = 32 \text{ A}, dI/dt = 100 \text{ A}/\mu\text{s}, V_{DD} = 60 \text{ V}, T_j = 150^\circ\text{C}$ (see <i>Figure 16: "Test circuit for inductive load switching and diode recovery times"</i> )	-	205		ns
$Q_{rr}$	Reverse recovery charge		-	1.8		$\mu\text{C}$
$I_{RRM}$	Reverse recovery current		-	17.6		A

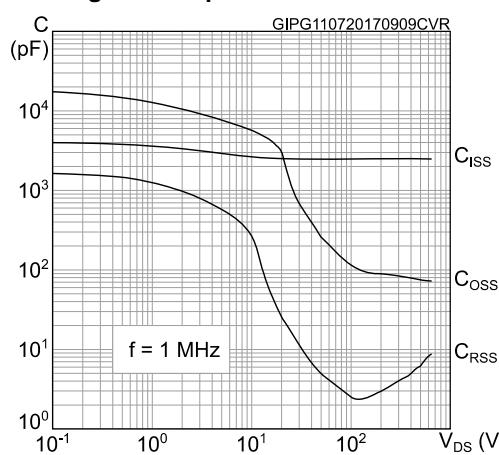
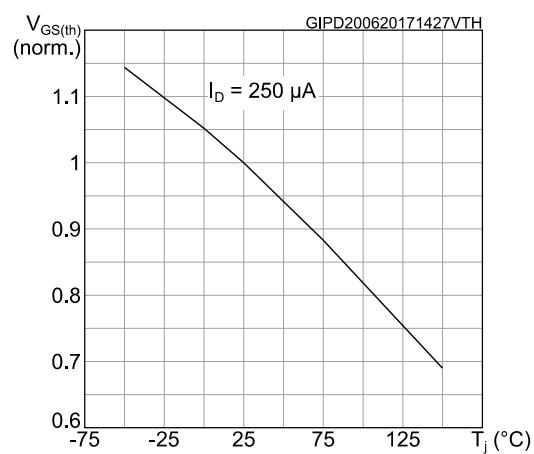
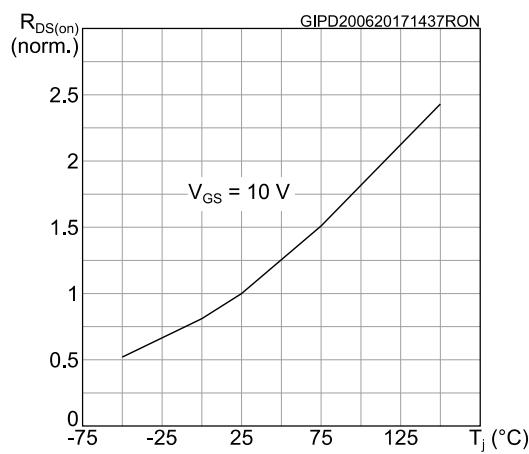
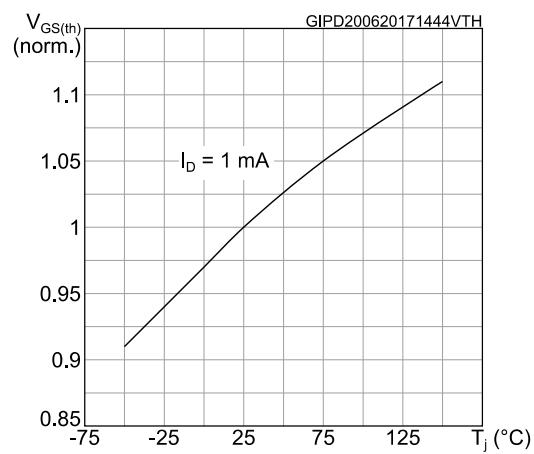
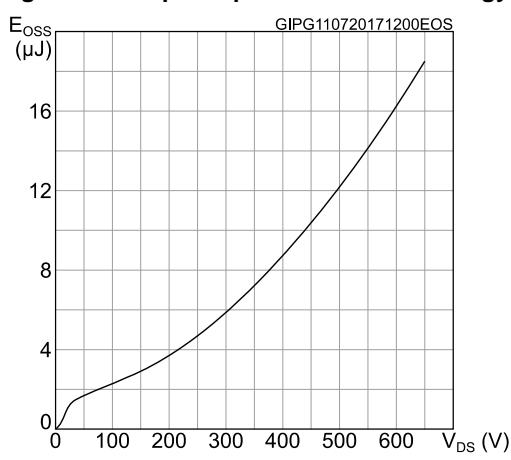
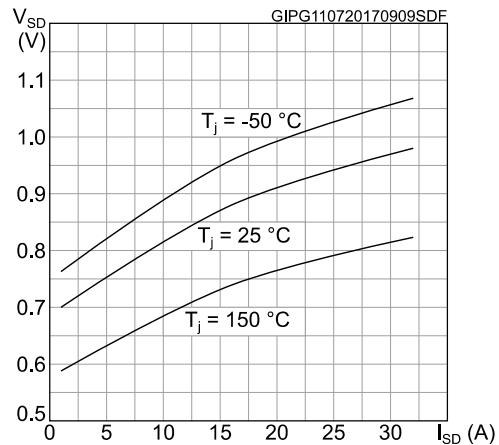
**Notes:**

(1)Pulse width is limited by safe operating area.

(2)Pulse test: pulse duration = 300  $\mu\text{s}$ , duty cycle 1.5%

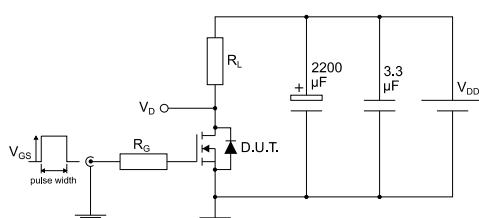
## 2.1 Electrical characteristics (curves)

**Figure 2: Safe operating area****Figure 3: Thermal impedance****Figure 4: Output characteristics****Figure 5: Transfer characteristics****Figure 6: Gate charge vs gate-source voltage****Figure 7: Static drain-source on-resistance**

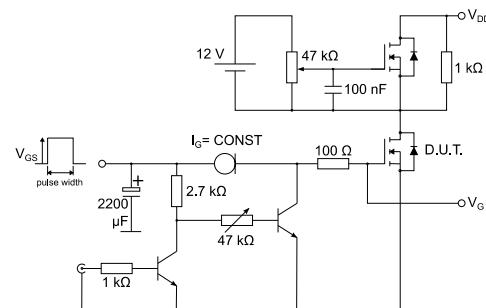
**Figure 8: Capacitance variations****Figure 9: Normalized gate threshold voltage vs temperature****Figure 10: Normalized on-resistance vs temperature****Figure 11: Normalized  $V_{(BR)DSS}$  vs temperature****Figure 12: Output capacitance stored energy****Figure 13: Source- drain diode forward characteristics**

### 3 Test circuits

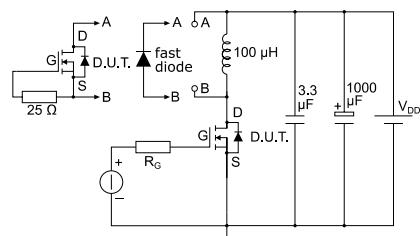
**Figure 14: Test circuit for resistive load switching times**



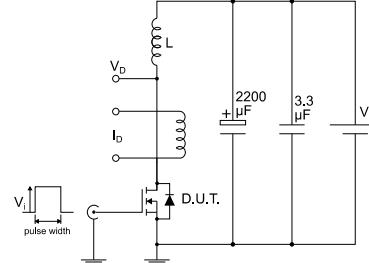
**Figure 15: Test circuit for gate charge behavior**



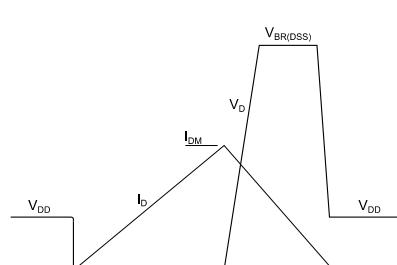
**Figure 16: Test circuit for inductive load switching and diode recovery times**



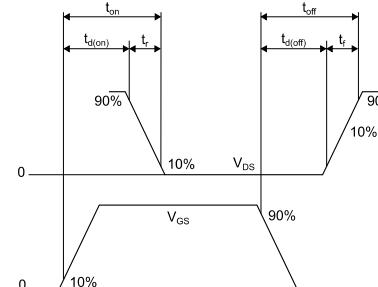
**Figure 17: Unclamped inductive load test circuit**



**Figure 18: Unclamped inductive waveform**



**Figure 19: Switching time waveform**

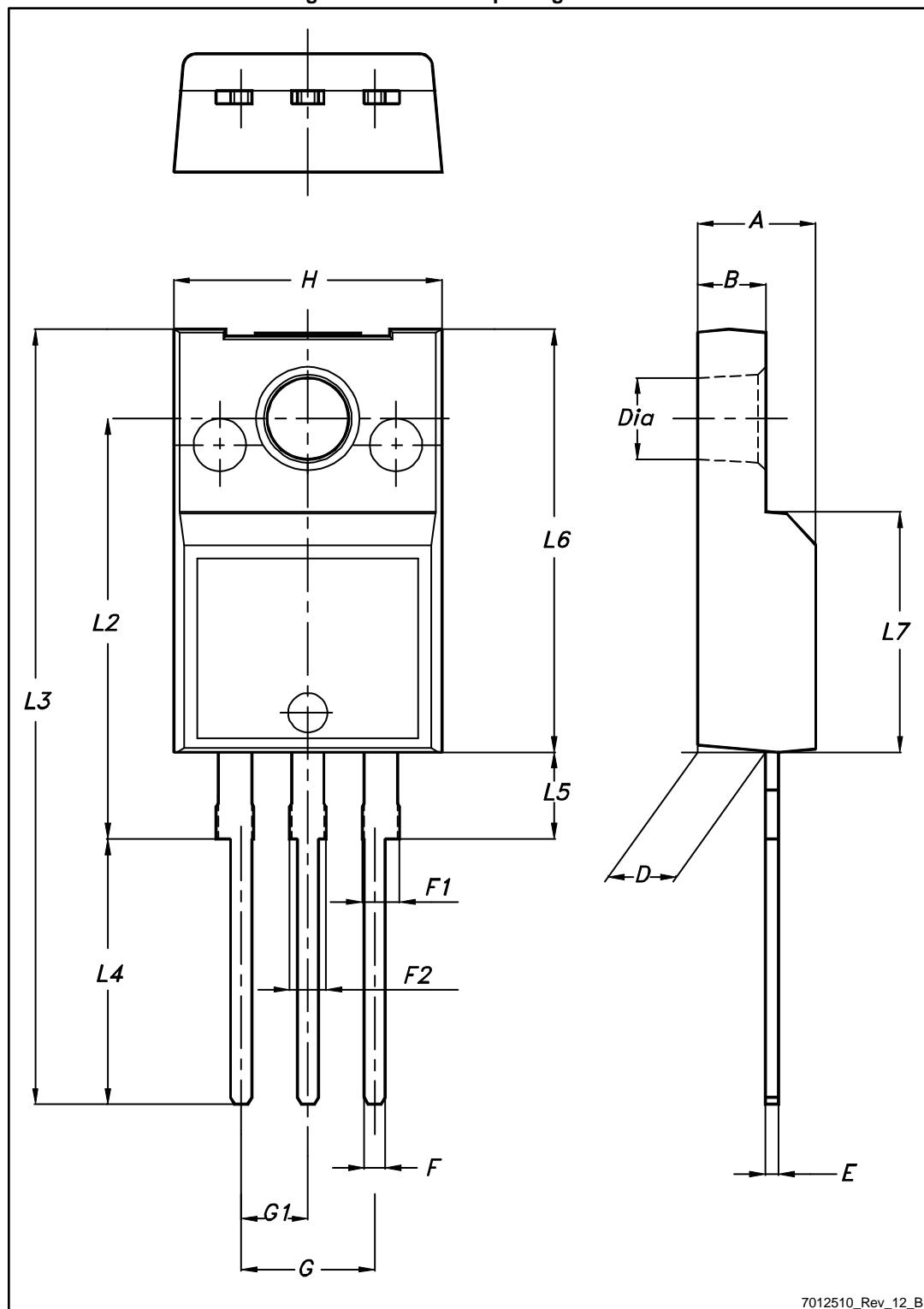


## 4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: [www.st.com](http://www.st.com).  
ECOPACK® is an ST trademark.

## 4.1 TO-220FP package information

Figure 20: TO-220FP package outline



7012510\_Rev\_12\_B

Table 9: TO-220FP package mechanical data

Dim.	mm		
	Min.	Typ.	Max.
A	4.4		4.6
B	2.5		2.7
D	2.5		2.75
E	0.45		0.7
F	0.75		1
F1	1.15		1.70
F2	1.15		1.70
G	4.95		5.2
G1	2.4		2.7
H	10		10.4
L2		16	
L3	28.6		30.6
L4	9.8		10.6
L5	2.9		3.6
L6	15.9		16.4
L7	9		9.3
Dia	3		3.2

## 5 Revision history

Table 10: Document revision history

Date	Revision	Changes
21-Jul-2017	1	Initial release
04-Dec-2017	2	Document status changed from preliminary to production data. Updated <i>Table 2: "Absolute maximum ratings"</i> and <i>Table 8: "Source-drain diode"</i> . Updated <i>Figure 2: "Safe operating area"</i> . Minor text changes.

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